



NSAI
Standards

Irish Standard
I.S. EN IEC 60749-12:2018

Semiconductor devices - Mechanical and climatic test methods - Part 12: Vibration, variable frequency

I.S. EN IEC 60749-12:2018

Incorporating amendments/corrigenda/National Annexes issued since publication:

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National Foreword

I.S. EN IEC 60749-12:2018 is the adopted Irish version of the European Document EN IEC 60749-12:2018, Semiconductor devices - Mechanical and climatic test methods - Part 12: Vibration, variable frequency

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EUROPEAN STANDARD

EN IEC 60749-12

NORME EUROPÉENNE

EUROPÄISCHE NORM

March 2018

ICS 31.080.01

Supersedes EN 60749-12:2002

English Version

**Semiconductor devices - Mechanical and climatic test methods -
Part 12: Vibration, variable frequency
(IEC 60749-12:2017)**

Dispositifs à semiconducteurs - Méthodes d'essais
mécaniques et climatiques - Partie 12: Vibrations,
fréquences variables
(IEC 60749-12:2017)

Halbleiterbauelemente - Mechanische und klimatische
Prüfverfahren - Teil 12: Schwingen, variable Frequenz
(IEC 60749-12:2017)

This European Standard was approved by CENELEC on 2018-01-17. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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EN IEC 60749-12:2018 (E)

European foreword

The text of document 47/2386/CDV, future edition 2 of IEC 60749-12, prepared by IEC/TC 47 "Semiconductor devices" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 60749-12:2018.

The following dates are fixed:

- latest date by which the document has to be (dop) 2018-10-17
implemented at national level by
publication of an identical national
standard or by endorsement
- latest date by which the national (dow) 2021-01-17
standards conflicting with the
document have to be withdrawn

This document supersedes EN 60749-12:2002.

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Endorsement notice

The text of the International Standard IEC 60749-12:2017 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following note has to be added for the standard indicated:

IEC 60068-2-6 NOTE Harmonized as EN 60068-2-6.

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